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# LTE RADIO TEST REPORT

Report No:STS1806067W10

Issued for

SOURCENEXT CORPORATION

Shiodome City Center 33F, 1-5-2 Higashi Shinbashi Minato-ku, Tokyo 105-7133, Japan

Product Name:	POCKETALK
Brand Name:	POCKETALK
Model Name:	W1PGK
Series Model:	W1PGG, W1PGW, W1PWG, W1PWK, W1PWW
FCC ID:	2AOJA-W1P
Test Standard:	47 CFR Part 2, 24(E)

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### **TEST RESULT CERTIFICATION**

Applicant's name ...... SOURCENEXT CORPORATION

Address ...... Shiodome City Center 33F, 1-5-2 Higashi Shinbashi Minato-ku,

Tokyo 105-7133, Japan

Manufacture's Name ...... JENESIS(SHENZHEN)CO.,LTD

Address ...... 3F,Building A,Dajiahao Plaza,Yuan 2nd Road 362,Baoan 28th

disctrict, Shenzhen, China

**Product description** 

Product Name..... POCKETALK

Brand Name ...... POCKETALK

Model Name .....: W1PGK

Series Model...... W1PGG, W1PGW, W1PWG, W1PWK, W1PWW

Test procedure.....: KDB 971168 D01 v03r01, ANSI C63.26 2015

This device described above has been tested by STS and the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report.

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Date of Test

Date of performance of tests ....... 28 June 2018~06 Aug. 2018

Date of Issue...... 06 Aug. 2018

Test Result......Pass

Testing Engineer :

(Chris chen)

Technical Manager:

(Sean she

Authorized Signatory:

(Vita Li)



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### **Revision History**

Rev.	Issue Date	ue Date Report NO. Effe		Contents
00	06 Aug. 2018	STS1806067W10	ALL	Initial Issue





### 1. TEST FACTORY & MEASUREMENT UNCERTAINTY

### 1.1 TEST FACTORY

Shenzhen STS Test Services Co., Ltd.

Add.: 1/F., Building B, Zhuoke Science Park, No.190, Chongqing Road,

Fuyong Street, Bao'an District, Shenzhen, Guangdong, China CNAS Registration No.: L7649; FCC Registration No.: 625569 IC Registration No.: 12108A; A2LA Certificate No.: 4338.01;

#### 1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement  $\mathbf{y} \pm \mathbf{U}$ , where expended uncertainty  $\mathbf{U}$  is based on a standard uncertainty multiplied by a coverage factor of  $\mathbf{k=2}$ , providing a level of confidence of approximately  $\mathbf{95}$  %.

No.	Item	Uncertainty
3	RF power,conducted	±0.71dB
5	All emissions,radiated(<1G) 30MHz-200MHz	±2.83dB
6	All emissions,radiated(<1G) 200MHz-1000MHz	±2.94dB
7	All emissions,radiated(>1G)	±3.03dB



### 2. GENERAL INFORMATION

### 2.1 TECHNICAL SPECIFICATIONS AND REGULATIONS

### 2.1.1 PRODUCT DESCRIPTION

A major technical description of EUT is described as following:

Product Name:	POCKETALK
Trade Name	POCKETALK
Model Name	W1PGK
Series Model	W1PGG, W1PGW, W1PWK, W1PWW
Model Difference	The structure of the circuit is the same, only the name of the model is different
	U.S. Bands:
	☑LTE FDD Band 2 ☐LTE FDD Band 4
Frequency Bands:	☐LTE FDD Band 5 ☐LTE FDD Band 7
	☐LTE FDD Band 12 ☐LTE FDD Band 13
	LTE FDD Band 17 LTE TDD Band 41
SIM CARD:	Only support single SIM Card.
Antenna:	PIFA Antenna
Antenna gain:	LTE Band 2: 0dBi
Power Supply:	DC 3.7V by battery
Battery parameter:	Capacity: 2200mAh, Rated Voltage: 3.7V
Extreme Vol. Limits:	DC 3.33 V to 4.07 V (Nominal DC3.7V)
Extreme Temp. Toler-	-30℃ to +50℃
ance:	-30 ( 10 +30 (
Hardware version number:	PT2_MB_V1.0
Software version number:	0.2.8P



### 2.1.2 PRODUCT SPECIFICATION SUBJECTIVE TO THIS STANDARD

Product Specification Subjective To This Standard						
Tx Frequency	LTE Band 2:1850~1910MHz					
Rx Frequency	LTE Band 2:1930 ~1990MHz					
Bandwidth	LTE Band 2: 1.4MHz / 3MHz / 5MHz / 10MHz / 15MHz / 20MHz					
Maximum Output Power Limit	LTE Band 2 : 22.24 dBm					
Type of Modulation	QPSK / 16QAM					





### 2.1.3 EMISSION DESIGNATOR

LTE Band 2 BW(MHz)	Emission Designator (26dBc)QPSK	Emission Designator (26dBc)16QAM
1.4	1M47G7D	1M47W7D
3	2M98G7D	2M87W7D
5	5M03G7D	5M15W7D
10	10M2G7D	9M90W7D
15	15M1G7D	15M1W7D
20	19M9G7D	19M7W7D





### 2.1.4 TEST CONFIGURATION OF EQUIPMENT UNDER TEST

Antenna port conducted and radiated test items listed below are performed according to KDB 971168 D01 v03r01 and ANSI C63.26 2015 Power Meas. License Digital Systems with maximum output power.Radiated measurements are performed by rotating the EUT in three different orthogonal test planes tofind the maximum emission.

- 1. The mark "v" means that this configuration is chosen for testing
- 2. The mark "-" means that this bandwidth is not supported.
- 3. The device is investigated from 30MHz to 10 times of fundamental signal for radiated

ITEMS Band		Bandwidth (MHz)		Modulation		RB#		Test Channel							
		1.4	3	5	10	15	20	QPSK	16QAM	1	Half	Full	L	М	Н
Max. Output Power	2	v	v	v	v	v	v	V	v	v	v	v	v	v	v
Peak&Avera Ratio	2						٧	V	V	V		V	٧	٧	٧
26dB&99% Bandwidth	2	v	v	v	٧	٧	٧	V	v			v	v	v	V
Conducted Band Edge	2	v	v	٧	v	٧	٧	V	v	v		v	v	v	٧
Conducted Spurious Emission	2	v	v	v	v	v	٧	٧	v	V			٧	v	v
Frequency Stability	2				٧			V				V		٧	
E.R.P.& E.I.R.P.	2	٧	V	٧	v	٧	V	٧	V	V			V	v	V
Radiated Spurious Emission	2	V	٧	٧	v	V	٧	v		V			٧	v	v



### 2.1.5 RELATED SUBMITTAL(S) / GRANT (S)

This submittal(s) (test report) is intended for filing to comply with the 47 CFR Part 2, 24(E), 27

### 2.1.6 SPECIAL ACCESSORIES

The battery and the charger, earphone supplied by the applicant were used as accessories and being tested with eut intended for fcc grant together.

### 2.1.7 EUT CONFIGURATION

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

#### 2.1.8 EUT EXERCISE

The Transmitter was operated in the maximum output power mode through Communication Tester. The TX frequency was fixed which was for the purpose of the measurements.



### 2.1.9 CONFIGURATION OF EUT SYSTEM

The EUT configuration for testing is installed on RF field strength measurement to meet the Commission's requirement and operating in a manner which intends to maximize its emission characteristics in a continuous normal application.

E-1 EUT

Table 2-1 Equipment Used in EUT System

Item	Equipment	Model No.	Serial No.	Note
N/A	N/A	N/A	N/A	N/A

### Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in <code>"Length\_"</code> column.



### 2.1.10 MEASUREMENT INSTRUMENTS

The radiated emission testing was performed according to the procedures of ANSI C63.26 2015 and FCC CFR 47 rules of 2.1046, 2.1047, 2.1049, 2.1051, 2.1053, 2.1055, 2.1057.

Kind of Equipment	Manufacturer	Type No.	Serial No.	Last Calibra- tion	Calibrated Until
Test Receiver	R&S	ESCI	101427	2017.10.15	2018.10.14
Wireless Communica- tions Test Set	R&S	CMW 500	131428	2018.03.11	2019.03.10
Bilog Antenna	TESEQ	CBL6111D	34678	2017.11.02	2018.11.01
Horn Antenna	Schwarzbeck	BBHA 9120D (1201)	9120D-1343	2017.10.27	2018.10.26
MXA SIGNAL Analyzer	Agilent	N9020A	MY49100060	2017.10.15	2018.10.14
Low frequency cable	N/A	R01	N/A	NCR	NCR
High frequency cable	SCHWARZBECK	AK9515H	SN-96286/96287	NCR	NCR
Signal Generator	Agilent	N5182A	MY46240556	2017.10.15	2018.10.14
Pre-mplifier (0.1M-3GHz)	EM	EM330	60538	2018.03.11	2019.03.10
PreAmplifier (1G-26.5GHz)	Agilent	8449B	60538	2017.10.15	2018.10.14
Temperature& Humidity test chamber	GZGONGWEN	GDS-250	080821	2017.10.15	2018.10.14
Band Reject fil- ter(1920-1980MHz)	COM-MW	ZBSF-1920-1980	0092	2017.10.15	2018.10.14
Band Reject fil- ter(880-915MHz)	COM-MW	ZBSF-C897.5-35	707	2017.10.15	2018.10.14
Band Reject fil- ter(1710-1785MHz)	COM-MW	ZBSF-C1747.5-75	708	2017.10.15	2018.10.14
Band Reject fil- ter(1850-1910MHz)	COM-MW	ZBSF-C1880-60	709	2017.10.15	2018.10.14
Band Reject fil- ter(2500-2570MHz)	COM-MW	ZBSF-C2535-70	710	2017.10.15	2018.10.14
Highpass Filter	WHKX7.0/18G-8SS	Wainwright	18	2017.10.15	2018.10.14



### 2. 1.11 MEASUREMENT RESULTS EXPLANATION EXAMPLE

For all conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator factorbetween EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

Offset = RF Cable Loss + Attenuator Factor.





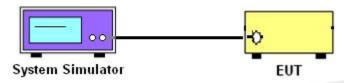
### 3. CONDUCTED OUTPUT POWER

### 3.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

#### 3.1.1 MEASUREMENT METHOD

A System Simulator Was Used To Establish Communication With The EUT. Its Parameters Were Set To Force The EUT Transmitting At Maximum Output Power. The Measured Power In The Radio Frequency On The Transmitter Output Terminals Shall Be Reported. configuration follows KDB 971168 D01 v03r01.

### 3.1.2 TEST SETUP



### 3.1.3 TEST PROCEDURES

- 1. The Transmitter Output Port Was Connected To The System Simulator.
- 2. Set EUT at maximum power through the system simulator.
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Measure and record the power level from the system simulator.



### 3.1.4 TEST RESULTS

### LTE BAND 2

	LTE Band 2 Maximum Average Power [dBm]									
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest				
1.4	1	0		22.08	22.05	22.19				
1.4	1	2		22.07	22.03	22.15				
1.4	1	5		21.94	21.91	22.02				
1.4	3	0	QPSK	21.71	21.83	21.88				
1.4	3	1	QI OIX	21.78	21.87	21.89				
1.4	3	2		21.76	21.85	21.9				
1.4	6	0		21.08	21.01	21.11				
1.4	1	0		20.66	20.94	20.91				
1.4	1	2		20.82	21.03	21.02				
1.4	1	5		20.72	20.94	20.89				
1.4	3	0	16-QAM	20.62	20.81	20.75				
1.4	3	1		20.67	20.78	20.75				
1.4	3	2		20.63	20.73	20.76				
1.4	6	0		19.88	19.9	19.95				
3	1	0		22.01	21.94	22.1				
3	1	7		22.06	22.04	22.18				
3	1	14		21.94	21.96	22.04				
3	8	0	QPSK	20.99	20.96	21.05				
3	8	4		21.02	21.02	21.08				
3	8	7		20.96	20.99	21.03				
3	15	0		20.85	20.89	20.96				
3	1	0		20.89	20.97	21				
3	1	7		21.01	21.13	21.07				
3	1	14		20.89	20.98	20.91				
3	8	0	16-QAM	19.91	20.02	20.05				
3	8	4		19.94	20.03	20				
3	8	7		19.93	19.99	19.96				
3	15	0		19.67	19.83	19.89				



LTE Band 2 Maximum Average Power [dBm]									
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest			
5	1	0		22.02	20.31	21.88			
5	1	12		22	20.06	21.7			
5	1	24		21.62	19.81	21.87			
5	12	0	QPSK	19.91	18.9	19.29			
5	12	6		20.72	18.95	19.34			
5	12	11		20.55	18.92	19.3			
5	25	0		20.77	18.88	19.26			
5	1	0		20.38	19.35	19.46			
5	1	12		20.24	19	19.73			
5	1	24		20.26	20.28	19.47			
5	12	0	16-QAM	19.68	19.41	18.21			
5	12	6		19.34	19.45	18.27			
5	12	11		19.36	18.61	18.28			
5	25	0		18.66	17.84	18.31			
10	1	0		19.93	20.49	20.58			
10	1	24		19.99	20.1	20.72			
10	1	49		19.78	20.05	20.34			
10	25	0	QPSK	18.97	18.99	19.43			
10	25	12		19.01	19	19.44			
10	25	24		19.01	19.01	19.44			
10	50	0		18.99	19	19.43			
10	1	0		19.6	19.71	19.32			
10	1	24		19.22	19.2	19.49			
10	1	49		18.96	19.22	19.43			
10	25	0	16-QAM	18.03	17.97	18.41			
10	25	12		18.06	17.99	18.46			
10	25	24		18.08	18.03	18.5			
10	50	0		17.95	17.94	18.34			



	LTE	Band 2 Maximi	um Average F	Power [dBm]		
BW [MHz]	RB Size	RB Offset	Mod	Lowest	Middle	Highest
15	1	0		22.09	22.07	22.21
15	1	37		21.82	21.81	21.96
15	1	74		21.58	21.53	21.74
15	36	0	QPSK	21.37	21.25	21.53
15	36	18		21.12	20.98	21.28
15	36	39		20.89	20.73	21.03
15	75	0		20.67	20.48	20.79
15	1	0		21.84	21.8	21.98
15	1	38		21.62	21.51	21.7
15	1	75		21.42	21.3	21.48
15	36	0	16-QAM	21.19	21.05	21.26
15	36	18		20.92	20.82	21.03
15	36	39		20.66	20.6	20.76
15	75	0		20.39	20.37	20.52
20	1	0		22.1	22.09	22.24
20	1	49		21.87	21.81	21.95
20	1	99		21.58	21.6	21.72
20	50	0	QPSK	21.34	21.38	21.45
20	50	24		21.11	21.17	21.17
20	50	49		20.89	20.91	20.91
20	100	0		20.6	20.68	20.65
20	1	0		21.84	21.85	21.95
20	1	49		21.62	21.62	21.71
20	1	99		21.35	21.35	21.44
20	50	0	16-QAM	21.09	21.12	21.17
20	50	24		20.83	20.86	20.97
20	50	49		20.57	20.59	20.71
20	100	0		20.37	20.42	20.44



### 4. PEAK-TO-AVERAGE RATIO

### 4.1 DESCRIPTION OF THE CONDUCTED OUTPUT POWER MEASUREMENT

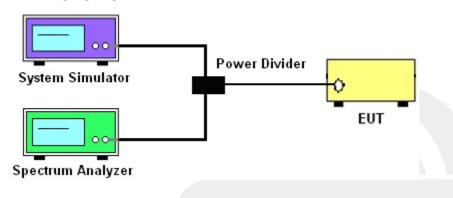
### 4.1.1 MEASUREMENT METHOD

Use one of the procedures presented in 4.1 to measure the total peak power and record as PPk. Use one of the applicable procedures presented 4.2 to measure the total average power and record as PAvg. Both the peak and average power levels must be expressed in the same logarithmic units (e.g., dBm). Determine the PAPR from:

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PAPR(dB) = PPk(dBm) - PAvg(dBm).

### 4.1.2 TEST SETUP



#### 4.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 5.7.2 and ANSI C63.26 2015 Section 5.2.3.4
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the peak and average power of the spectrum analyzer
- 5. Record the deviation as Peak to Average Ratio.

	LTE								
LTE BW	1.4M	1.4M 3M 5M 10M 15M 2							
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz			
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz			
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz			
Detector	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG	PK/AVG			
Trace	Max	Max	Max	Max	Max	Max			
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto			



### 4.1.4 TEST RESULTS

### LTE BAND 2

	LTE Band 2 PAR [dB]											
BW	RB	Madulation		Lowest			Middle			Highest		
[MHz]	Size	Modulation	PEAK	AVG	P-A	PEAK	AVG	P-A	PEAK	AVG	P-A	
20	1	ODCK	25.47	21.6	3.67	24.46	21.91	2.45	25.14	22.18	2.78	
20	100	QPSK	25.61	20.12	4.56	25.51	20.03	4.55	25.64	20.41	4.44	
20	1	40.001	26.15	21.22	4.44	24.9	21.28	3.41	25.47	21.58	3.73	
20	100	16-QAM	26.31	20.22	5.25	26.59	20.36	5.39	26.45	20.15	5.27	
	Limit			≤13dB								

**NOTE:Test chart See Appendix D** 





### 5. RADIATED POWER AND EFFECTIVE ISOTROPIC RADIATED POWER

#### 5.1 DESCRIPTION OF THE ERP/EIRP MEASUREMENT

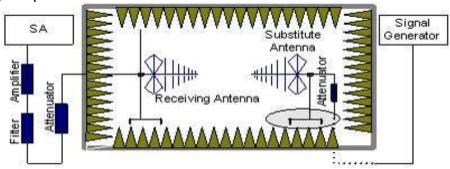
#### 5.1.1 MEASUREMENT METHOD

Effective radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas. License Digital Systems. Mobile and portable (hand-held) stations operating are limited to average ERP, Equivalent isotropic radiated power output measurements by substitution method according to ANSI C63.26 2015, and the spectrum analyzer configuration follows KDB 971168 D01 Power Meas, Mobile and portable (hand-held) stations operating are limited to average EIRP.

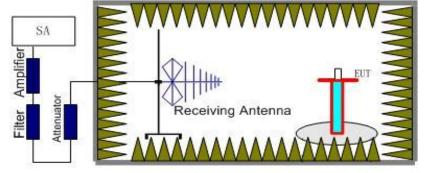
### 5.1.2 TEST SETUP

The procedure of radiated spurious emissions is as follows:

a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx( dBuV )+CL( dB )+SA( dB )+Gain( dBi )-107( dBuV to dBm )The SA is calibrated using following setup.



b) EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic were measured with peak detector and 1MHz bandwidth.



Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Power=PMea+ARpl



### 5.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01v03r01 Section 5.6. and ANSI C63.26 2015 Section 5.2.
- 2. The EUT was placed on a non-conductive rotating platform 1.5 meters high in a semi-anechoic chamber. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and a spectrum analyzer with Peak detector.
- 3. During the measurement, the system simulator parameters were set to force the EUTtransmitting at maximum output power. The maximum emission was recorded from analyzer power level (LVL) from the 360 degrees rotation of the turntable and the test antenna raised and lowered over a range from 1 to 4 meters in both horizontally and vertically polarized orientations.
- 4. Effective Isotropic Radiated Power (EIRP) was measured by substitution method according to ANSI C63.26 2015. The EUT was replaced by dipole antenna (substitution antenna) at same location, and then a known power from S.G. was applied into the dipole antenna through a Tx cable, and then recorded the maximum Analyzer reading through raised and lowered the test antenna. The correction factor (in dB) = S.G. Tx Cable loss + Substitution antenna gain -Analyzer reading. Then the EUT's EIRP was calculated with the correction factor, EIRP/ERP= LVL +Correction factor

5.RB Set greater than bandwidth, Vb Set spectrum analyzer Maximum support.





### 5.1.4 TEST RESULTS

Note:Test is divided into three directions, X/Y/Z. X pattern for the worst.

### LTE Band 2

			Rad	iated Power	(EIRP) for L	TE Band 2	/ 1.4M				
	_					Resul	t				
Modulation	RB		Channel	S G.Level	Cable	Gain	DMoos	Polarization	Conclusion		
Modulation	0:	04	Channel	(dBm) los		PMeas E.I.R.P(dBm)	Of Max.	Conclusion			
	Size	e Offset			1055	(dbi)	E.I.K.F (ubili)	EIRP			
	1	0	Lowest	11.18	2.37	10.40	19.21	Horizontal	Pass		
	1	0	Middle	11.21	2.39	10.42	19.24	Horizontal	Pass		
QPSK	1	0	Highest	11.33	2.40	10.44	19.37	Horizontal	Pass		
QFSK	1	0	Lowest	12.68	2.37	10.40	20.71	Vertical	Pass		
	1	0	Middle	12.7	2.39	10.42	20.73	Vertical	Pass		
	1	0	Highest	12.8	2.40	10.44	20.84	Vertical	Pass		
	1	0	Lowest	9.77	2.37	10.40	17.80	Horizontal	Pass		
	1	0	Middle	10.18	2.39	10.42	18.21	Horizontal	Pass		
16QAM	1	0	Highest	10.33	2.40	10.44	18.37	Horizontal	Pass		
TOQAW	1	0	Lowest	11.23	2.37	10.40	19.26	Vertical	Pass		
	1	0	Middle	11.56	2.39	10.42	19.59	Vertical	Pass		
	1	0	Highest	11.64	2.40	10.44	<mark>19.68</mark>	Vertical	Pass		
Limit	EIRP<	EIRP<2W=33dBm									



			Rac	liated Power	(EIRP) for	LTE Band 2	2/3M			
		חם				Result	t			
Modulation		RB	Channel	C C L avial	Cable	Gain	PMeas	Polarization	Conclusion	
iviodulation	Size	Offset		S G.Level (dBm)	loss		E.I.R.P(dBm)	Of Max.	Conclusion	
	Size	Onset				(dBi)		EIRP		
	1	0	Lowest	11.32	2.37	10.40	19.35	Horizontal	Pass	
	1	0	Middle	11.03	2.39	10.42	19.06	Horizontal	Pass	
QPSK	1	0	Highest	11.36	2.40	10.44	19.40	Horizontal	Pass	
QFSK	1	0	Lowest	12.67	2.37	10.40	20.70	Vertical	Pass	
	1	0	Middle	12.52	2.39	10.42	20.55	Vertical	Pass	
	1	0	Highest	12.82	2.40	10.44	<b>20.86</b>	Vertical	Pass	
	1	0	Lowest	10.22	2.37	10.40	18.25	Horizontal	Pass	
	1	0	Middle	10.35	2.39	10.42	18.38	Horizontal	Pass	
16QAM	1	0	Highest	10.22	2.40	10.44	18.26	Horizontal	Pass	
TOQAW	1	0	Lowest	11.6	2.37	10.40	19.63	Vertical	Pass	
	1	0	Middle	11.72	2.39	10.42	<mark>19.75</mark>	Vertical	Pass	
	1	0	Highest	11.66	2.40	10.44	19.70	Vertical	Pass	
Limit	EIRP<2W=33dBm									

			Rad	diated Power	(EIRP) for	LTE Band	2 / 5M		
		20							
Modulation	ľ	RB	Chamal	S G.Level	Cable	Cain	PMeas	Polarization	Conclusion
Modulation	Size	Offset	Channel			Gain	E.I.R.P(dBm)	Of Max.	Conclusion
	Size	Oliset		(dBIII)	loss	(dBi)	E.I.K.P (UDIII)	EIRP	
	1	0	Lowest	11.42	2.37	10.40	19.45	Horizontal	Pass
	1	0	Middle	9.54	2.39	10.42	17.57	Horizontal	Pass
QPSK	1	0	Highest	11.06	2.40	10.44	19.10	Horizontal	Pass
QPSK	1	0	Lowest	12.75	2.37	10.40	20.78	Vertical	Pass
	1	0	Middle	10.88	2.39	10.42	18.91	Vertical	Pass
	1	0	Highest	12.52	2.40	10.44	20.56	Vertical	Pass
	1	0	Lowest	9.63	2.37	10.40	17.66	Horizontal	Pass
	1	0	Middle	8.56	2.39	10.42	16.59	Horizontal	Pass
16QAM	1	0	Highest	8.7	2.40	10.44	16.74	Horizontal	Pass
IOQAM	1	0	Lowest	10.98	2.37	10.40	19.01	Vertical	Pass
	1	0	Middle	10.06	2.39	10.42	18.09	Vertical	Pass
	1	0	Highest	10.2	2.40	10.44	18.24	Vertical	Pass
Limit	EIRP<2W=33dBm								



			Rad	iated Power	(EIRP) for I	TE Band 2	/ 10M				
		RB				Resul	t				
Modulation	ľ	ΛD.	Ob a mad	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion		
iviodulation	Size	Offset	Channel		loss			Of Max.	Conclusion		
	Size	Oliset		(dBm)	1088	(dBi)	E.I.R.P(dBm)	EIRP			
	1	0	Lowest	9.24	2.37	10.40	17.27	Horizontal	Pass		
	1	0	Middle	9.2	2.39	10.42	17.23	Horizontal	Pass		
QPSK	1	0	Highest	9.81	2.40	10.44	17.85	Horizontal	Pass		
QFSK	1	0	Lowest	10.7	2.37	10.40	18.73	Vertical	Pass		
	1	0	Middle	10.58	2.39	10.42	18.61	Vertical	Pass		
	1	0	Highest	11.3	2.40	10.44	19.34	Vertical	Pass		
	1	0	Lowest	8.27	2.37	10.40	16.30	Horizontal	Pass		
	1	0	Middle	8.13	2.39	10.42	16.16	Horizontal	Pass		
16QAM	1	0	Highest	8.6	2.40	10.44	16.64	Horizontal	Pass		
TOQAW	1	0	Lowest	9.73	2.37	10.40	17.76	Vertical	Pass		
	1	0	Middle	9.56	2.39	10.42	17.59	Vertical	Pass		
	1	0	Highest	9.9	2.40	10.44	17.94	Vertical	Pass		
Limit	EIRP	EIRP<2W=33dBm									

			Rad	iated Power	(EIRP) for I	_TE Band 2	/ 15M		
		RB							
Modulation	ΝĎ		Channel	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion
Modulation	Size	Offset	Chamile	(dBm)	loss	(dBi)	E.I.R.P(dBm)	Of Max.	Conclusion
	Size	Dize Oliset		(ubiii)	1055	(dDI)		EIRP	
	1	0	Lowest	11.35	2.37	10.40	19.38	Horizontal	Pass
	1	0	Middle	11.29	2.39	10.42	19.32	Horizontal	Pass
QPSK	1	0	Highest	11.51	2.40	10.44	19.55	Horizontal	Pass
Qrok	1	0	Lowest	12.74	2.37	10.40	20.77	Vertical	Pass
	1	0	Middle	12.75	2.39	10.42	20.78	Vertical	Pass
	1	0	Highest	12.93	2.40	10.44	20.97	Vertical	Pass
	1	0	Lowest	11.06	2.37	10.40	19.09	Horizontal	Pass
	1	0	Middle	11.04	2.39	10.42	19.07	Horizontal	Pass
16QAM	1	0	Highest	11.1	2.40	10.44	19.14	Horizontal	Pass
TOGAM	1	0	Lowest	12.53	2.37	10.40	20.56	Vertical	Pass
	1	0	Middle	12.48	2.39	10.42	20.51	Vertical	Pass
	1	0	Highest	12.59	2.40	10.44	20.63	Vertical	Pass
Limit	EIRP<2W=33dBm								



			Rad	iated Power	(EIRP) for I	LTE Band 2	/ 20M				
		<b>.</b>			Result						
Modulation	RB		Observat	S G.Level	Cable	Gain	PMeas	Polarization	Conclusion		
wodulation	Size	Offset	Channel	(dBm)	loss	(dBi)	E.I.R.P(dBm)	Of Max.	Conclusion		
	Size	Oliset				(dBi)		EIRP			
	1	0	Lowest	11.34	2.37	10.40	19.37	Horizontal	Pass		
	1	0	Middle	11.33	2.39	10.42	19.36	Horizontal	Pass		
QPSK	1	0	Highest	11.64	2.40	10.44	19.68	Horizontal	Pass		
QFSK	1	0	Lowest	12.72	2.37	10.40	20.75	Vertical	Pass		
	1	0	Middle	12.73	2.39	10.42	20.76	Vertical	Pass		
	1	0	Highest	13	2.40	10.44	21.04	Vertical	Pass		
	1	0	Lowest	11.18	2.37	10.40	19.21	Horizontal	Pass		
	1	0	Middle	11.23	2.39	10.42	19.26	Horizontal	Pass		
16QAM	1	0	Highest	11.12	2.40	10.44	19.16	Horizontal	Pass		
IOQAW	1	0	Lowest	12.61	2.37	10.40	20.64	Vertical	Pass		
	1	0	Middle	12.54	2.39	10.42	20.57	Vertical	Pass		
	1	0	Highest	12.6	2.40	10.44	<mark>20.64</mark>	Vertical	Pass		
Limit	EIRP<	IRP<2W=33dBm									



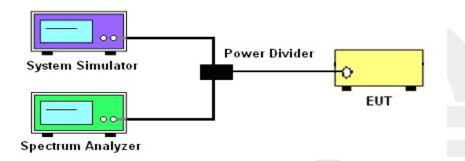
#### 6. OCCUPIED BANDWIDTH

#### 6.1 DESCRIPTION OF OCCUPIED BANDWIDTH MEASUREMENT

#### 6.1.1 MEASUREMENT METHOD

- 1. The occupied bandwidth is the width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5% of the total mean transmitted power.
- 2. The 26 db emission bandwidth is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated 26 db below the maximum in-band spectral density of the modulated signal. spectral density (power per unit bandwidth) is to be measured with a detector of resolution bandwidth equal to approximately 1.0% of the emission bandwidth.

#### 6.1.2 TEST SETUP



### 6.1.3 TEST PROCEDURES

- 1. The testing follows FCC KDB 971168 D01 v03r01 Section 4.1.and 4.2
- 2. The EUT was connected to spectrum and system simulator via a power divider
- 3. Select lowest, middle, and highest channels for each band and different modulation.
- 4. Set the test probe and measure the Occupied Bandwidth of the spectrum analyzer
- Measure and record the Occupied Bandwidth from the Spectrum Analyzer.

	LTE									
LTE BW	1.4M	3M	5M	10M	15M	20M				
Span	3MHz	6MHz	10MHz	20MHz	30MHz	40MHz				
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz				
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz				
Detector	PK	PK	PK	PK	PK	PK				
Trace	Max	Max	Max	Max	Max	Max				
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto				



### 6.1.4 MEASUREMENT RESULT

### LTE BAND 2

		LTE	Band 2 Ba	ndwidth [M	lHz]			
BW [MHz]	Mod	Low	est	Mid	dle	Highest		
בייווון איס	IVIOU	26dB BW	99% BW	26dB BW	99% BW	26dB BW	99% BW	
1.4	QPSK	1.472	1.1077	1.329	1.0967	1.464	1.1141	
1.4	16-QAM	1.417	1.1062	1.312	1.1001	1.470	1.1089	
3	QPSK	2.866	2.6808	2.868	2.6842	2.976	2.6793	
3	16-QAM	2.863	2.6779	2.867	2.6752	2.872	2.6773	
5	QPSK	5.025	4.5292	5.016	4.5268	5.014	4.5283	
5	16-QAM	5.025	4.5308	5.148	4.5311	5.020	4.5377	
10	QPSK	10.18	8.9702	9.981	8.9461	9.930	8.9525	
10	16-QAM	9.796	8.9533	9.896	8.9522	9.842	8.9568	
15	QPSK	14.78	13.487	14.42	13.528	15.09	13.543	
15	16-QAM	15.06	13.528	15.08	13.515	15.07	13.520	
20	QPSK	19.60	17.959	19.58	17.908	19.87	17.978	
20	16-QAM	19.72	17.959	19.70	17.952	19.65	17.936	

**NOTE:Test chart See Appendix A** 



### 7. CONDUCTED BAND EDGE

#### 7.1 DESCRIPTION OF CONDUCTED BAND EDGE MEASUREMENT

#### 7.1.1 MEASUREMENT METHOD

#### 1. §22.917(a)

For operations in the 824 – 849 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100kHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

### 2. §24.238 (a)

For operations in the 1850-1910 and 1930-1990 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1MHz bandwidth. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed

### 3. §27.53 (h)

For operations in the 1710 – 1755 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 1 MHz bandwidth. However, in the 1MHz bands immediately outside and adjacent to the licensee's frequency block, a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

### 4. §27.53(m)(4)

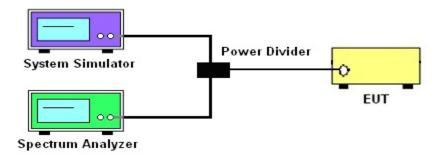
For operations in the 2500 MHz ~ 2570 MHz band this section, the attenuation factor shall be not less than 40 + 10 log (P) dB on all frequencies between the channel edge and 5 megahertz from the channel edge, 43 + 10 log (P) dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and 55 + 10 log (P) dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth as defined in paragraph (m)(6) of this section. In addition,the attenuation factor shall not be less that 43 + 10 log (P) dB on all frequencies between 2490.5 MHzand 2496 MHz and 55 + 10 log (P) dB at or below 2490.5 MHz. Mobile Satellite Service licenseesoperating on frequencies below 2495 MHz may also submit a documented interference complaintagainst BRS licensees operating on channel BRS Channel 1 on the same terms and conditions as adjacent channel BRS or EBS licensees.

#### 5. §27.53 (g)

For operations in the 698 -746 MHz band, the FCC limit is 43 + 10log10(P[Watts]) dB below the transmitter power P(Watts) in a 100 kHz bandwidth. However, in the 100 kilohertz bands immediately outside and adjacent to a licensee's frequency block, a resolution bandwidth of at least 30 kHz may be employed.



### 7.1.2 TEST SETUP



### 7.1.3 TEST PROCEDURES

- 1. The testing FCC KDB 971168 D01 v03r01 Section 6.0. and ANSI C63.26 2015 Section 5.7.
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The band edges of low and high channels for the highest RF powers were measured. Set RBW >= 1% EBW in the 1MHz band immediately outside and adjacent to the band edge.
- 4. Set spectrum analyzer with RMS/AVG detector
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.
- 6. The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)
- = P(W) [43 + 10log(P)] (dB)
- = [30 + 10log(P)] (dBm) [43 + 10log(P)] (dB)
- = -13dBm.

#### Band 7:

- = P(W) [55 + 10log(P)] (dB)
- = [30 + 10log(P)] (dBm) [55 + 10log(P)] (dB)
- = -25dBm.

	LTE								
LTE BW	1.4M	1.4M 3M 5M 10M 15M 20							
Span	12MHz	13MHz	15MHz	20MHz	25MHz	30MHz			
RBW	30kHz	30kHz	100kHz	100kHz	300kHz	300kHz			
VBW	100kHz	100kHz	300kHz	300kHz	1000kHz	1000kHz			
Detector	RMS	RMS	RMS	RMS	RMS	RMS			
Trace	Max	Max	Max	Max	Max	Max			
Sweep Count	Auto	Auto	Auto	Auto	Auto	Auto			

### 7.1.4 MEASUREMENT RESULT

NOTE: Test chart See Appendix B



### 8. CONDUCTED SPURIOUS EMISSIO

#### 8.1 DESCRIPTION OF CONDUCTED SPURIOUS EMISSION MEASUREMENT

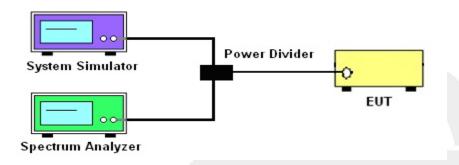
#### 8.1.1 MEASUREMENT METHOD

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7:

The power of any emission outside of the authorized operating frequency ranges must be lower than the transmitter power (P) by a factor of at least 55 + 10 log (P) dB.

It is measured by means of a calibrated spectrum analyzer and scanned from 30 MHz up to a frequency including its 10th harmonic.

#### 8.1.2 TEST SETUP



#### 8.1.3 TEST PROCEDURES

- 1.The testing FCC KDB 971168 D01 v03r01 Section 6.0. and ANSI C63.26 2015 Section 5.7.
- 2. The EUT was connected to spectrum analyzer and system simulator via a power divider.
- 3. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement
- 4. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.
- 5. The RF fundamental frequency should be excluded against the limit line in the operating frquency band.
- 6. The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)
- = P(W) [43 + 10log(P)] (dB) = [30 + 10log(P)] (dBm) [43 + 10log(P)] (dB)
- = -13dBm.

For Band 7:P(W)- [43 + 10log(P)] (dB) =-25dBm

	LTE						
LTE BW	1.4M	3M	5M	10M	15M	20M	
Span	Auto	Auto	Auto	Auto	Auto	Auto	
RBW	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	1000kHz	
VBW	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	3000kHz	
Detector	PK	PK	PK	PK	PK	PK	
Trace	Max	Max	Max	Max	Max	Max	

8.1.4 TEST RESULTS

NOTE: Test chart See Appendix C



#### 9. RADIATED SPURIOUS EMISSION

#### 9.1 DESCRIPTION OF RADIATED SPURIOUS EMISSION

#### 9.1.1 MEASUREMENT METHOD

The radiated spurious emission was measured by substitution method according to ANSI C63.26 2015. The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 43 + 10 log (P) dB. For Band 7 The power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitter power (P) by a factor of at least 55 + 10 log (P) dB. For Band. The spectrum is scanned from 30 MHz up to a frequency including its 10th harmonic.

### 5.1.2 Test Setup

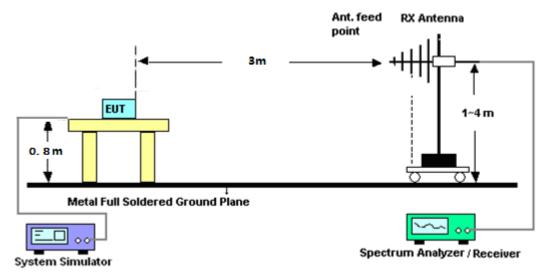
The procedure of radiated spurious emissions is as follows:

- a) Pre-calibration With pre-calibration method, the Radiated Spurious Emissions(RSE) is calculated as, RSE=Rx ( dBuV ) +CL ( dB ) +SA ( dB ) +Gain ( dBi ) -107 ( dBuV to dBm ) The SA is calibrated using following setup.
- b) EUT was placed on a 1.5 meter high non-conductive stand at a 3 meter test distance from the receive antenna. A receiving antenna was placed on the antenna mast 3 meters from the test item for emission measurements. The height of receiving antenna is 0.8m. The test setup refers to figure below. Detected emissions were maximized at each frequency by rotating the test item and adjusting the receiving antenna polarization. The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 10th harmonic were measured with peak detector and 1MHz bandwidth.

Radiated emissions measurements were made only at the upper, middle, and lower carrier frequencies It was decided that measurements at these three carrier frequencies would be sufficient to demonstrate compliance with emissions limits because it was seen that all the significant spurs occur well outside the band and no radiation was seen from a carrier in one block of any band into any of the other blocks.

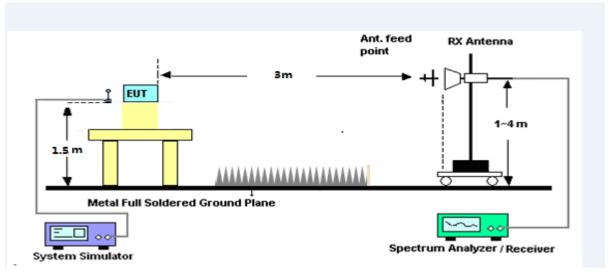
The substitution method is used. Substitution values at each frequency are measured before and saved to the test software. A "reference path loss" is established and the ARpl is the attenuation of "reference path loss", and including the gain of receive antenna, the gain of the preamplifier, the cable loss and the air loss. The measurement results are obtained as described below: Power=PMea+ARpl

For radiated test from 30MHz to 1GHz





#### For radiated test from above 1GHz



### 9.1.3 TEST PROCEDURES

- 1. The testing FCC KDB 971168 D01 Section 5.8 and ANSI C63.26 2015 Section 5.5.
- 2. The EUT was placed on a rotatable wooden table with 0.8 meter above ground.
- 3. The EUT was set 3 meters from the receiving antenna, which was mounted on the antenna tower.
- 4. The table was rotated 360 degrees to determine the position of the highest spurious emission.
- 5. The height of the receiving antenna is varied between one meter and four meters to search the maximum spurious emission for both horizontal and vertical polarizations
- 6. Make the measurement with the spectrum analyzer's RBW = 1MHz, VBW = 3MHz, taking the record of maximum spurious emission.
- 7. A horn antenna was substituted in place of the EUT and was driven by a signal generator.
- 8. Tune the output power of signal generator to the same emission level with EUT maximum spurious emission.
- 9. Taking the record of output power at antenna port.
- 10. Repeat step 7 to step 8 for another polarization.
- 11. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.

The limit line is derived from 43 + 10log(P)dB below the transmitter power P(Watts)

- = P(W) [43 + 10log(P)] (dB)
- $= [30 + 10\log(P)] (dBm) [43 + 10\log(P)] (dB)$
- = -13dBm

#### For Band 7:

The limit line is derived from 55 + 10log(P)dB below the transmitter power P(Watts)

- = [30 + 10log(P)] (dBm) [55 + 10log(P)] (dB)
- = -25dBm

EIRP (dBm) = S.G. Power – Tx Cable Loss + Tx Antenna Gain

ERP (dBm) = EIRP - 2.15



### 9.1.4 TEST RESULTS

### LTE BAND 2

L DAND Z								
LTE Band 2 / 1	.4MHz / QF	PSK / RB Si	ize 1 Offse	t 0/ The W	orst Test R	esults for	Lowest	
Fragues ov/MII=)	S G.Lev	Ant/dD:\	Lana	PMea	Limit	Margin	Dolority	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3701.37	-34.45	12.60	12.93	-34.78	-13.00	-21.78	Н	
5551.77	-34.63	13.10	17.11	-38.64	-13.00	-25.64	Н	
7402.60	-32.91	11.50	22.20	-43.61	-13.00	-30.61	Н	
3701.37	-35.47	12.60	12.93	-35.80	-13.00	-22.80	V	
5551.77	-34.59	13.10	17.11	-38.60	-13.00	-25.60	V	
7402.60	-32.87	11.50	22.20	-43.57	-13.00	-30.57	V	
LTE Band 2 / 1	.4MHz / QI	PSK / RB S	ize 1 Offse	et 0/ The W	orst Test R	esults for	Middle	
Fragues av (MIII-)	S G.Lev	A == 4 ( =1 D ; )		PMea	Limit	Margin	Doloritu	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3760.18	-33.85	12.60	12.93	-34.18	-13.00	-21.18	Н	
5640.05	-34.32	13.10	17.11	-38.33	-13.00	-25.33	Н	
7520.25	-33.27	11.50	22.20	-43.97	-13.00	-30.97	Н	
3760.18	-35.52	12.60	12.93	-35.85	-13.00	-22.85	V	
5640.05	-34.07	13.10	17.11	-38.08	-13.00	-25.08	V	
7520.25	-31.88	11.50	22.20	-42.58	-13.00	-29.58	V	
LTE Band 2 / 1	.4MHz / QP	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for l	Highest	
	S G.Lev	Λ := 4 ( «ID:)	1	PMea	Limit	Margin	Delevity	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3818.57	-34.62	12.60	12.93	-34.95	-13.00	-21.95	Н	
5727.52	-34.48	13.10	17.11	-38.49	-13.00	-25.49	Н	
7637.07	-32.28	11.50	22.20	-42.98	-13.00	-29.98	Н	
3818.57	-35.72	12.60	12.93	-36.05	-13.00	-23.05	V	
5727.52	-34.20	13.10	17.11	-38.21	-13.00	-25.21	V	
7637.07	-31.72	11.50	22.20	-42.42	-13.00	-29.42	V	

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 2/3	3MHz / QP	SK / RB Siz	e 1 Offset	0/ The Wo	orst Test Re	sults for L	owest
Frequency(MHz)	S G.Lev	A (( ID.))		PMea	Limit	Margin	<b>5</b>
	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3703.15	-34.88	12.60	12.93	-35.21	-13.00	-22.21	Н
5554.60	-34.76	13.10	17.11	-38.77	-13.00	-25.77	Н
7406.89	-32.56	11.50	22.20	-43.26	-13.00	-30.26	Н
3703.15	-34.62	12.60	12.93	-34.95	-13.00	-21.95	V
5554.60	-34.91	13.10	17.11	-38.92	-13.00	-25.92	V
7406.89	-32.09	11.50	22.20	-42.79	-13.00	-29.79	V
LTE Band 2 /	3MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	sults for N	Middle
	S G.Lev	/		PMea	Limit	Margin	Dalavitu
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3760.14	-34.16	12.60	12.93	-34.49	-13.00	-21.49	Н
5640.19	-34.88	13.10	17.11	-38.89	-13.00	-25.89	Н
7520.22	-32.56	11.50	22.20	-43.26	-13.00	-30.26	Н
3760.14	-35.50	12.60	12.93	-35.83	-13.00	-22.83	V
5640.19	-34.85	13.10	17.11	-38.86	-13.00	-25.86	V
7520.22	-33.01	11.50	22.20	-43.71	-13.00	-30.71	V
LTE Band 2 / 3	MHz / QPS	SK / RB Siz	e 1 Offset	0/ The Wo	rst Test Re	sults for H	ighest
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Dolority
Frequency(MHZ)	(dBm)	Anii(ubi)	LUSS	(dBm)	(dBm)	(dB)	Polarity
3816.50	-34.38	12.60	12.93	-34.71	-13.00	-21.71	Н
5725.13	-34.97	13.10	17.11	-38.98	-13.00	-25.98	Н
7633.56	-33.44	11.50	22.20	-44.14	-13.00	-31.14	Н
3816.50	-35.76	12.60	12.93	-36.09	-13.00	-23.09	V
5725.13	-34.60	13.10	17.11	-38.61	-13.00	-25.61	V
7633.56	-32.14	11.50	22.20	-42.84	-13.00	-29.84	V

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 2 / 5MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest								
_	S G.Lev	4 ((171)		PMea	Limit	Margin	5	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3705.01	-34.36	12.60	12.93	-34.69	-13.00	-21.69	Н	
5558.16	-34.19	13.10	17.11	-38.20	-13.00	-25.20	Н	
7410.43	-33.22	11.50	22.20	-43.92	-13.00	-30.92	Н	
3705.01	-35.67	12.60	12.93	-36.00	-13.00	-23.00	V	
5558.16	-34.34	13.10	17.11	-38.35	-13.00	-25.35	V	
7410.43	-32.37	11.50	22.20	-43.07	-13.00	-30.07	V	
LTE Band 2 /	5MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	sults for N	/liddle	
Fragues (MIII)	S G.Lev	A 4 ( -ID : )		PMea	Limit	Margin	Doloritu	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3760.04	-34.29	12.60	12.93	-34.62	-13.00	-21.62	Н	
5639.81	-34.71	13.10	17.11	-38.72	-13.00	-25.72	Н	
7519.92	-33.02	11.50	22.20	-43.72	-13.00	-30.72	Н	
3760.04	-35.85	12.60	12.93	-36.18	-13.00	-23.18	V	
5639.81	-35.22	13.10	17.11	-39.23	-13.00	-26.23	V	
7519.92	-32.81	11.50	22.20	-43.51	-13.00	-30.51	V	
LTE Band 2 / 5	MHz / QPS	SK / RB Siz	e 1 Offset	0/ The Wo	rst Test Re	sults for H	ighest	
Frequency(MHz)	S G.Lev	Ant(dBi)	Loop	PMea	Limit	Margin	Dolority	
Frequency(MHZ)	(dBm)	Anii(ubi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3814.11	-33.82	12.60	12.93	-34.15	-13.00	-21.15	Н	
5721.25	-34.26	13.10	17.11	-38.27	-13.00	-25.27	Н	
7628.69	-33.24	11.50	22.20	-43.94	-13.00	-30.94	Н	
3814.11	-34.93	12.60	12.93	-35.26	-13.00	-22.26	V	
5721.25	-34.78	13.10	17.11	-38.79	-13.00	-25.79	V	
7628.69	-33.17	11.50	22.20	-43.87	-13.00	-30.87	V	

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line. Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 2 / 1	0MHz / QP	SK / RB Si	ze 1 Offse	t 0/ The We	orst Test Re	esults for L	_owest	
- (A411.)	S G.Lev	A (( ID')	);)	PMea	Limit	Margin	<b>5</b>	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity	
3710.64	-34.00	12.60	12.93	-34.33	-13.00	-21.33	Н	
5565.69	-35.47	13.10	17.11	-39.48	-13.00	-26.48	Н	
7420.81	-32.37	11.50	22.20	-43.07	-13.00	-30.07	Н	
3710.64	-35.68	12.60	12.93	-36.01	-13.00	-23.01	V	
5565.69	-34.68	13.10	17.11	-38.69	-13.00	-25.69	V	
7420.81	-31.99	11.50	22.20	-42.69	-13.00	-29.69	V	
LTE Band 2 / 1	0MHz / QF	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for l	Middle	
	S G.Lev	G.Lev Ant/dB:)	Loss	PMea	Limit	Margin	Dalavitu	
Frequency(MHz)	(dBm)	Ant(dBi)		(dBm)	(dBm)	(dB)	Polarity	
3759.81	-34.29	12.60	12.93	-34.62	-13.00	-21.62	Н	
5640.23	-34.24	13.10	17.11	-38.25	-13.00	-25.25	Н	
7519.95	-32.56	11.50	22.20	-43.26	-13.00	-30.26	Н	
3759.81	-35.80	12.60	12.93	-36.13	-13.00	-23.13	V	
5640.23	-34.39	13.10	17.11	-38.40	-13.00	-25.40	V	
7519.95	-32.33	11.50	22.20	-43.03	-13.00	-30.03	V	
LTE Band 2 / 1	0MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	sults for h	lighest	
Frequency(MHz)	S G.Lev	Ant(dBi)	Loss	PMea	Limit	Margin	Polarity	
Frequency(MHZ)	(dBm)	Anii(ubi)	LUSS	(dBm)	(dBm)	(dB)	Polarity	
3809.36	-34.67	12.60	12.93	<del>-35.00</del>	-13.00	-22.00	Н	
5714.01	-35.36	13.10	17.11	-39.37	-13.00	-26.37	Н	
7618.11	-33.60	11.50	22.20	-44.30	-13.00	-31.30	Н	
3809.36	-34.69	12.60	12.93	-35.02	-13.00	-22.02	V	
5714.01	-34.44	13.10	17.11	-38.45	-13.00	-25.45	V	
7618.11	-32.90	11.50	22.20	-43.60	-13.00	-30.60	V	

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line. Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 2 / 1	5MHz / QP	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test Re	esults for I	_owest
	S G.Lev			PMea	Limit	Margin	
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3716.06	-33.88	12.60	12.93	-34.21	-13.00	-21.21	Н
5574.04	-34.88	13.10	17.11	-38.89	-13.00	-25.89	Н
7618.39	-32.22	11.50	22.20	-42.92	-13.00	-29.92	Н
3716.06	-34.76	12.60	12.93	-35.09	-13.00	-22.09	V
5574.04	-34.98	13.10	17.11	-38.99	-13.00	-25.99	V
7618.39	-33.13	11.50	22.20	-43.83	-13.00	-30.83	V
LTE Band 2 / 1	5MHz / QF	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for	Middle
Fragues av/MII=)	S G.Lev	S G.Lev	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity
3759.79	-34.22	12.60	12.93	-34.55	-13.00	-21.55	Н
5640.02	-34.57	13.10	17.11	-38.58	-13.00	-25.58	Н
7520.06	-33.38	11.50	22.20	-44.08	-13.00	-31.08	Н
3759.79	-34.59	12.60	12.93	-34.92	-13.00	-21.92	V
5640.02	-34.70	13.10	17.11	-38.71	-13.00	-25.71	V
7520.06	-31.94	11.50	22.20	-42.64	-13.00	-29.64	V
LTE Band 2 / 1	5MHz / QP	SK / RB Siz	ze 1 Offset	t 0/ The Wo	orst Test Re	sults for h	lighest
Fraguanay/MUz)	S G.Lev	۸ nt/dDi\	Loss	PMea	Limit	Margin	Dolority
Frequency(MHz)	(dBm)	Ant(dBi)	LUSS	(dBm)	(dBm)	(dB)	Polarity
3803.51	-33.80	12.60	12.93	-34.13	-13.00	-21.13	Н
5705.44	-34.13	13.10	17.11	-38.14	-13.00	-25.14	Н
7607.39	-33.45	11.50	22.20	-44.15	-13.00	-31.15	Н
3803.51	-35.17	12.60	12.93	-35.50	-13.00	-22.50	V
5705.44	-34.36	13.10	17.11	-38.37	-13.00	-25.37	V
7607.39	-32.83	11.50	22.20	-43.53	-13.00	-30.53	V

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



LTE Band 2 / 20MHz / QPSK / RB Size 1 Offset 0/ The Worst Test Results for Lowest									
[	S G.Lev	۸ ۱/ ما <b>ا</b>	1	PMea	Limit	Margin	Delevity		
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity		
3721.00	-34.33	12.60	12.93	-34.66	-13.00	-21.66	Н		
5581.48	-34.22	13.10	17.11	-38.23	-13.00	-25.23	Н		
7441.72	-32.78	11.50	22.20	-43.48	-13.00	-30.48	Н		
3721.00	-35.02	12.60	12.93	-35.35	-13.00	-22.35	V		
5581.48	-34.22	13.10	17.11	-38.23	-13.00	-25.23	V		
7441.72	-32.28	11.50	22.20	-42.98	-13.00	-29.98	V		
LTE Band 2 / 2	0MHz / QF	SK / RB Si	ze 1 Offse	t 0/ The W	orst Test R	esults for	Middle		
Fraguenov(MHz)	S G.Lev	S G.Lev	S G.Lev	۸ pt/dDi\	Loop	PMea	Limit	Margin	Dolority
Frequency(MHz)	(dBm)	Ant(dBi)	) Loss	(dBm)	(dBm)	(dB)	Polarity		
3760.19	-33.77	12.60	12.93	-34.10	-13.00	-21.10	Н		
5640.20	-34.07	13.10	17.11	-38.08	-13.00	-25.08	Н		
7520.26	-33.10	11.50	22.20	-43.80	-13.00	-30.80	Н		
3760.19	-34.89	12.60	12.93	-35.22	-13.00	-22.22	V		
5640.20	-34.05	13.10	17.11	-38.06	-13.00	-25.06	V		
7520.26	-31.77	11.50	22.20	-42.47	-13.00	-29.47	V		
LTE Band 2 / 2	0MHz / QP	SK / RB Siz	ze 1 Offset	0/ The Wo	orst Test Re	sults for I	lighest		
Frequency(MHz)	S G.Lev	۸ pt/dDi\	Loop	PMea	Limit	Margin	Dolority		
Frequency(MHz)	(dBm)	Ant(dBi)	Loss	(dBm)	(dBm)	(dB)	Polarity		
3798.55	-34.23	12.60	12.93	-34.56	-13.00	-21.56	Н		
5697.17	-34.71	13.10	17.11	-38.72	-13.00	-25.72	Н		
7597.11	-32.54	11.50	22.20	-43.24	-13.00	-30.24	Н		
3798.55	-34.81	12.60	12.93	-35.14	-13.00	-22.14	V		
5697.17	-35.02	13.10	17.11	-39.03	-13.00	-26.03	V		
7597.11	-32.33	11.50	22.20	-43.03	-13.00	-30.03	V		

Remark: Spurious emissions within 30-1000MHz were found more than 20dB below limit line.

Test is divided into three directions, X/Y/Z. X pattern for the worst.



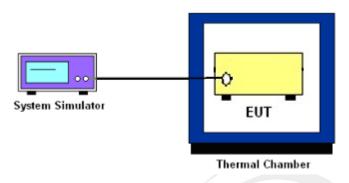
### 10. FREQUENCY STABILITY

#### 10.1 DESCRIPTION OF FREQUENCY STABILITY MEASUREMENT

#### 10.1.1 MEASUREMENT METHOD

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5ppm) of the center frequency.

### 10.1.2 Test Setup



### 10.1.3 TEST PROCEDURES FOR TEMPERATURE VARIATION

- 1. The EUT was set up in the thermal chamber and connected with the system simulator.
- 2. With power OFF, the temperature was decreased to -30°C and the EUT was stabilized before testing. Power was applied and the maximum change in frequency was recorded within one minute.
- 3. With power OFF, the temperature was raised in 10°C step up to 50°C. The EUT was stabilized at each step for at least half an hour. Power was applied and the maximum frequency change was recorded within one minute.

### 10.1.4 TEST PROCEDURES FOR VOLTAGE VARIATION

- 1. The testing follows FCC KDB 971168 D01v01r03 Section 9.0.
- 2. The EUT was placed in a temperature chamber at 25±5° C and connected with the system simlator.
- 3. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
- 4. The variation in frequency was measured for the worst case.



### 10.1.4 MEASUREMENT RESULT

### LTE BAND 2

LTE Band 2 (QPSK) / 1880MHz / BW10M								
Temperature	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result			
(°C)	(Volt)	(Hz)	(ppm)					
50		14.19	0.008					
40	Normal Wal	16.48	0.009	- 2.5ppm	PASS			
30		15.75	0.008					
20		25.74	0.014					
10	Normal Vol-	20.27	0.011					
0	tage	34.88	0.019					
-10		34.55	0.018		PASS			
-20		27.80	0.015					
-30		35.26	0.019					
25	Maximum Voltage	29.13	0.015					
25	BEP	36.11	0.019					

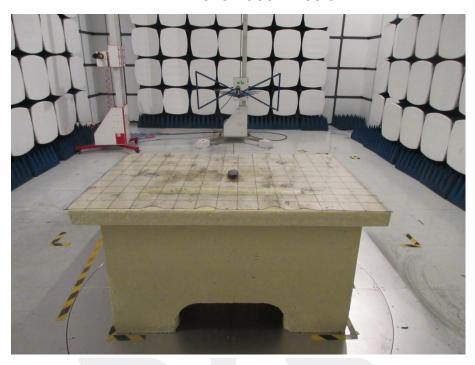
LTE Band 2 (QPSK) / 1880MHz / BW20M									
Temperature (°C)	Voltage	Freq. Dev.	Freq. Dev.	Limit	Result				
	(Volt)	Volt) (Hz) (ppm)							
50		35.14	0.019						
40		26.63	0.014						
30		15.18	0.008	2.5ppm	PASS				
20	Normal -	29.51	0.016						
10		12.63	0.007						
0	Voltage	30.69	0.016						
-10		32.49	0.017						
-20		12.27	0.007						
-30		27.60	0.015						
25	Maximum	24.14	0.012						
25	Voltage	24.14	0.013						
25	BEP	30.72	0.016						

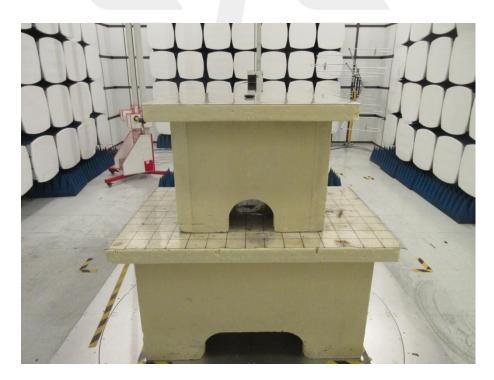
Note: 1. Normal Voltage = 3.7V.; Battery End Point (BEP) = 3.33V.; Maximum Voltage = 4.07 V 2. Note: The frequency fundamental emissions stay within the authorized frequency block based on the frequency deviation measured is small.



## **PHOTOS OF TEST SETUP**

RADIATED SPURIOUS EMISSION





\*\* \* \* \* \* END OF THE REPORT \* \* \* \* \*